

# Search Notes



Application/Control No.

10/506,302

Examiner

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Applicant(s)/Patent under Reexamination

ISHIHARA ET AL.

Art Unit

2834

## SEARCHED

Class	Subclass	Date	Examiner
310	261	10/17/2006	HN
310	216	10/17/2006	HN
310	217	10/17/2006	HN
310	218	10/17/2006	HN
update search	All	4/7/07	HN
update search	All	5/4/07	HN

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
310	261	5/6/07	HN

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
PG Pub Text Search, see interference search print out	5/6/07	HN